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# A Nonparametric Repetitive Sampling DEWMA Control Chart Based on Linear Prediction

## AMBREEN SHAFQAT<sup>©</sup><sup>1</sup>, ZHENSHENG HUANG<sup>1</sup>, MUHAMMAD ASLAM<sup>©</sup><sup>2</sup>, AND MUHAMMAD SHUJAAT NAWAZ<sup>3,4</sup>

<sup>1</sup>Department of Statistics and Financial Mathematics, School of Sciences, Nanjing University of Science and Technology, Nanjing 210094, China

<sup>2</sup>Department of Statistics, Faculty of Science, King Abdulaziz University, Jeddah 21589, Saudi Arabia

Corresponding author: Zhensheng Huang (stahzs@126.com)

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**ABSTRACT** Distribution-free control charts can be useful in statistical process control (SPC) when only limited or no information about the distribution of the data of the process is available. In this paper, a linear prediction related double exponentially weighted moving average (DEWMA) sign control chart using a repetitive sampling scheme (RSNPDEBLP) has been considered for a binomially distributed process variable to improve the efficiency of detecting small drifts in its place of small changes. The proposed RSNPDEBLP control chart is assessed in average run length (ARL) for the various values of sample sizes. The efficiency of the proposed RSNPDEBLP control chart is compared with the existing EWMA and DEWMA sign control charts using single sampling and repetitive sampling schemes in terms of ARLs. When there are small changes in the process after the stabilization period, the proposed control chart is used to control small trends rather than small shifts.

**INDEX TERMS** Binomial distribution, control chart, DEWMA, EWMA, linear prediction, repetitive sampling, sign statistic.

### I. INTRODUCTION

Variation exists in all types of manufacturing process and can be divided into a natural and unnatural variation [1]. The natural variation is inherent and its presence is supposed to be statistically in control(IC) in the process. Moreover, the unnatural variation is not the best and it arises due to some assignable causes of variations like machine error and faulty material etc. Unnatural variations affect the performance of the manufacturing process. Hence, a famous statistician Walter A. Shewhart [2] designed some control charts which are commonly used for such type of variation to identify and eliminate the unnatural variation from the process. The Shewhart control charts are suitable for detecting a large shift in the industrial process and unable to detect a small shift in the process. However, references [3] and [4] introduced cumulative sum (CUSUM) and exponentially weighted moving average (EWMA) control charts which are more efficient than the traditional control charts for quick detection of small

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shifts. The application of control chart techniques is not only limited to manufacturing industry products, but it has been used in many other disciplines, like health care [5], analytical laboratories [6], [7], nuclear engineering [8], education [9] and many other fields.

Several control charts have been designed with numerous objectives for checking the quality of variables of interest through the control of individual characteristics. Some control charts are the best for detecting the large variations in the mean level of the variable importance, like the traditional  $\bar{X}$  control chart. Whereas other control charts have been designed to perceive small modifications, for example, EWMA and double exponentially weighted moving average (DEWMA) control charts. However for the first time, Roberts [3] developed the EWMA control chart and Shamma and Shamma [10] introduced the DEWMA control chart. Since then, these charts have been designed by many other researchers. The extension of the EWMA technique to the DEWMA technique was also presented by Zhang and Chen [11]. But, both DEWMA control chart schemes and their conclusions are the same.

<sup>&</sup>lt;sup>3</sup>Higher Education Department, Government of the Punjab, Lahore 54000, Pakistan

<sup>&</sup>lt;sup>4</sup>Department of Statistics, National College of Business Administration and Economics, Lahore 54660, Pakistan



Although, [12] presented the DEWMA control chart for monitoring a commonaly distributed quality characteristic of interest. Research about EWMA and DEWMA control chart were designed as a reference given, [13] developed the nonparametric robustness of EWMA and DEWMA control charts, Zhang *et al.* [14] also explored the DEWMA control chart scheme for Poisson processes, [15] worked on comparing the characteristics of EWMA and DEWMA control charts. Alkahtani and Schaffer [16] designed a multivariate DEWMA control chart for identifying changes in the mean direction of a multivariate normal distributed quality of interest

Meanwhile, the above literature reflects that some of these control charts deal with the identifying a change at the mean-level and others deal with the revealing of a difference in variation. However, in experiments, sometimes it is essential to detect small trends or enlarged paths rather than a change in the processes. That is a small linear variation from the actual value of variable interest. Consequently, this ongoing change intends to identify small drifts in the procedure which may occur due to the device friction and many others similar causes. However, such type phenomenon can be observed in different administrative activities and manufacturing process of various products. Thus, till now no control chart is developed to determine the small trends in the process for non-normal data. Nevertheless, [17], [29] have designed the usual control charts by using the linear drift. The effectiveness of repetitive sampling technique of fixing small trends in a process has not been investigated in the existing literature. For the first time [17] studied this literature and predisposed the SPC society to encompass research in this area, so as to increase the information about trend revealing. Reference [27] proposed the use of a smoothing technique to forecast the demand of goods. Meanwhile, [28] showed smoothing techniques which are well known in the business to produce forecasting and are also essential for predicting the demand for services and goods. The [29] context proposed a parametric DEWMA control chart based on Linear prediction for detecting the small drift instead of shifts by using the normal distribution according to the fundamental theorem of exponential smoothing proposed by [30].

As mentioned above, the control charts have been used to check the quality of the product. However, these control charts are designed and presented by different ways and methods in the literature. In SPC, different sampling schemes are used to make the performance of the nonparametric and parametric control charts more efficient. Like as, reference [18] used the variable sampling interval (VSI) for developing the EWMA control chart. Some other sampling schemes such as multiple dependent sampling (MDS) and double sampling (DS) scheme have been used to increase the efficiency of the control charts in detecting the shift in the process [19] worked on control chart using DS scheme. The repetitive group sampling (RGS) is an efficient scheme than the single sampling in sample size plans and in *ARLs* in

control chart. In the repetitive sampling, the process to select a sample size is repeated if the experimenter is in-decision at the first sample information. In DS, the decision about the state of the control chart is taken on the basis of combined information of two samples. Therefore, RGS scheme is simple to operate and different from the DS scheme also, the RGS scheme is different from the VSI scheme because the RS scheme adjusts the control limits instead of the sampling interval.

For the first time, [20] and [21] proposed the sampling plans using RGS scheme and proved the efficiency over the single sampling. The control chart using RGS were introduced by [22]–[24]. The Design of hybrid EWMA and a new  $S^2$  control chart have been proposed by [25], [26] proposed hybrid EWMA and variance control charts using the RGS. Reference [36] proposed a control chart using RGS when observations are unclear and indeterminate by using the neutrosophic statistics. Later on, [37] designed an EWMA and DEWMA control chart for the non-normal process using RGS.

Recently, [29] introduced a DEWMA control chart based on linear prediction for small drift in place of shift under the assumption of normality. In the present study, we extend this idea by proposing a new DEWMA control chart by using a RGS scheme under the assumption of non-normality. The proposed control chart is expected to perform better than that of other non-normality based EWMA and DEWMA control charts. The proposed chart shows the efficiency in detecting the changes in the process as compared to the existing control charts. Moreover, the current study is divided into the following sections: A complete description of the proposed chart is given in section 2 that includes the design structure of the proposed control chart, background of nonparametric EWMA and DEWMA control charts including the design structure of existing control charts, and algorithm. In section 3, the results of the proposed chart are described. In section 4, the performance of the proposed chart with existing control charts are made. Real-life implementation of the proposed chart is given in section 5 whereas the conclusion is summarized in section 6.

## II. THE DESIGN OF NONPARAMETRIC LINEAR PREDICTION BASED DEWMA CONTROL CHART STRUCTURE

Let  $Y_i$  be a random variable generated using the arcsine transformation of binomial distribution which follows a normal distribution, initially  $Y_i \sim N(\sin^{-1}\sqrt{p_0}, 1/4n)$ . Let  $Z_i$  shows the DEWMA statistic which is defined as  $Z_i' = \lambda Z_i + (1 - \lambda)Z_i'$ , where  $Z_i$  is the EWMA sign statistic which can be calculated as  $Z_i = \lambda Y_i + (1 - \lambda)Z_{i-1}$ . The operational process of the DEWMA is based on upper and lower control limits. The EWMA and DEWMA control charts work efficiently for small shifts, but when the procedure needs a small change with the non-normal data set, the proposed control chart work more efficiently as compared to EWMA and DEWMA control charts.



## A. BACKGROUND OF NONPARAMETRIC EWMA AND DEWMA SIGN STATISTIC STRUCTURES

This section of paper provides the background of the EWMA and DEWMA sign statistic is explained in [22], [32], [33]. Let suppose that the quality characteristic X has a T target value and Y = X - T be the deviation of the process from the target value. But, process proportion is p = P(Y > 0). The process is declared IC when p = 0.5 and OOC when  $p \neq 0.5$ . Several random sample sizes  $n, X_1, X_2, X_3, \ldots, X_n$  is nominated at each subgroup from the procedure for examining. Define as;

$$I_j = \begin{cases} 1, & \text{if } Y_j > 0 \text{ for } j = 1, 2, \dots, n \\ 0, & \text{otherwise,} \end{cases}$$

Let M be the total number of values for  $Y_j > 0$ . That is defined as:

$$M = \sum_{i=1}^{n} I_i \tag{1}$$

Let, M follows the binomial distribution with parameters n and p = 0.5 for the IC process. If  $M_i$  is the  $i^{th}$  sequentially recorded value of such M, then the EWMA control chart is explained by Montgomery [34] and for above-mentioned variable EWMA sign statistic  $S_i$  is given as follows:

$$S_i = \lambda M_i + (1 - \lambda)S_{i-1} \tag{2}$$

where  $0 < \lambda < 1$  and the mean of  $S_i$  is used as the initial values of the EWMA sign statistics, i.e.,  $S_0 = np_0 = n/2$ . The mean can be shown below:

$$E(S_i) = \frac{n}{2} \tag{3}$$

The variance of EWMA statistic  $S_i$  can be defined as below:

$$Var(S_i) = \frac{\lambda}{2 - \lambda} [1 - (1 - \lambda)^{2i}] (\frac{n}{4}) \tag{4}$$

For large values of i,  $(1-(1-\lambda)^{2i})$  is equal to 1 and asymptotic variance becomes:

$$Var_{asym}(S_i) = (\frac{\lambda}{2-\lambda})(\frac{n}{4})$$
 (5)

But the EWMA sign control chart is not worked the best for getting the fixed required value of IC average run length like  $ARL_0 = 370,500$  etc., when  $p_0 = 0.5$ . This is happened due to binomial distribution because it is discrete distribution and asymmetrical for a small sample size. So, the possible solution for getting the stabile values of  $ARL_0$  is to use the Arcsine transformation described by [35]. Let  $Y_i = \sin^{-1} \sqrt{(M_i/n)}$  be the arcsine transformation and  $(Y_i)$  has an approximately normally distributed with mean and variance i.e.,  $Y_i \sim N(\sin^{-1} \sqrt{p_0}, 1/4n)$ . For IC process the mean of arcsine transformation  $Y_i$  is  $\sin^{-1} \sqrt{0.5}$ . The control chart using the EWMA sign statistic based on  $Y_i$  is defined as:

$$Z_i = \lambda Y_i + (1 - \lambda)Z_{i-1} \tag{6}$$

where  $Z_0 = \sin^{-1}\sqrt{p_0}$  and  $\lambda \in (0,1]$  be a smoothing constant. Consequently, the mean and variance of transformed EWMA sign control chart are  $E(Z_i) = \sin^{-1}\sqrt{p_0}$  and  $Var(Z_i) = \lambda/((2-\lambda)4n)$  for the large value of i the term  $1 - (1-\lambda)^{2i}$ ) approaches to unity. The control limits of EWMA sign and arcsine control chart for the single sampling can be written as:

$$UCL/LCL = \frac{n}{2} \pm k \sqrt{\frac{\lambda n}{(2 - \lambda)4}}$$

$$UCL/LCL = \sin^{-1}(\sqrt{(0.5)}) \pm k \sqrt{\frac{\lambda n}{(2 - \lambda)4n}}$$

## 1) EXISTING NONPARAMETRIC EWMA SIGN CONTROL CHART USING REPETITIVE SAMPLING

More details of the EWMA sign statistic control chart which is based on a repetitive sampling scheme (RSNPSE) explained in [22]. According to [22], the control limits for existing EWMA control chart for repetitive sampling can be written as:

$$UCL_1/LCL_1 = \frac{n}{2} \pm k_1 \sqrt{\frac{\lambda n}{(2-\lambda)4}}$$

$$CL = \frac{n}{2}$$

$$UCL_2/LCL_2 = \frac{n}{2} \pm k_2 \sqrt{\frac{\lambda n}{(2-\lambda)4}}$$

where  $k_1$  and  $k_2$  ( $k_1 \ge k_2 > 0$ ) are the coefficient of the control limits, which is the distance from the centre line to both control limits. So the nonparametric EWMA sign control chart using repetitive sampling (RSNPSE) is declared as out-of-control if  $Z_i \ge UCL_1$  or  $Z_i \le LCL_1$ .

## 2) EXISTING NONPARAMETRIC ARCSINE MODIFIED EWMA SIGN STATISTIC CONTROL CHART

The modified EWMA sign control chart under the arcsine transformation (NPASME) developed by [33]. They designed the NPASME by adding an extra coordinated term in traditional EWMA sign statistic. The formulation of the NPASME control chart statistic is written as:

$$M'_{i} = \lambda Y_{i} + (1 - \lambda)M'_{i-1} + L(Y_{i} - Y_{i-1})$$

where  $Y_i = \sin^{-1} \sqrt{(M_i/n)}$  that can calculate by following the procedure of section (II.A) and  $L = -\lambda/2$ . The mean and variance of  $M_i'$  are  $\sin^{-1}(\sqrt{(0.5)})$  and  $\lambda + 2\lambda L + 2L^2/((2-\lambda)4n)$ . The initial value of the  $M_i'$  control chart is set equal to the mean of  $Y_i$ . Thus, the control limits of NPASME are defined as:

$$UCL/LCL = \sin^{-1}(\sqrt{(0.5)}) \pm k\sqrt{\frac{\lambda + 2\lambda L + 2L^2}{(2-\lambda)4n}}$$

The process is declared in-control if  $LCL \leq M_i' \leq UCL$ . Otherwise, the process is deemed to be out-of-control. For more detail of modified EWMA sign control chart, reader may refer to [33]



### B. EXISTING NONPARAMETRIC DOUBLE ARCSINE EWMA SIGN CONTROL CHART (NPASDE)

First time Shamma and Shamma [10] developed a DEWMA control chart statistics which is defined as:

$$Z_{i}' = \lambda Z_{i} + (1 - \lambda) Z_{i-1}'$$
(7)

where  $Z_i$  is an EWMA control statistics which can calculate by using the Eq. 6. The mean of DEWMA control statistics can be shown as:

$$E(Z_i) = \sin^{-1} \sqrt{p_0} \tag{8}$$

The variance of the DEWMA control statistic for the large value i (asymptotic variance) can be written as: Detail can be seen in Appendix A. A.

$$Var_{asym}(Z_i) = \frac{\lambda(2 - 2\lambda + \lambda^2)}{(2 - \lambda)^3 (4n)}$$
(9)

The asymptotic arcsine sign DEWMA control chart limits for single sampling

$$UCL/LCL = \sin^{-1}\sqrt{p_0} \pm k\sqrt{\frac{\lambda(2-2\lambda+\lambda^2)}{(2-\lambda)^3(4n)}}$$

More detail for the calculation of DEWMA control chart can be obtained in [10], [15].

### C. PROPOSED NONPARAMETRIC LINEAR PREDICTION BASED DEWMA SIGN CONTROL CHART USING REPETITIVE SAMPLING

In this section, we present the design and operational procedure of the proposed control chart. The proposed nonparametric linear prediction based DEWMA control chart using repetitive sampling (RSNPDEBLP) is designed using the fundamental theorem explained by reference [30]. A linear prediction can be forecast by a DEWMA with the linear relationship by using the below equation:

$$F_{(i+t)} = a_i + b_i t \tag{10}$$

where  $F_{i+t}$  is the forecast in the t period (t = 1) and the detail of intercept and slop ( $a_i$  and  $b_i$ ) below

$$a_i = 2Z_i - Z_i'$$

$$b_i = \frac{\lambda}{1 - \lambda} (Z_i - Z_i')$$

We will present the design of three control charts using the statistic  $F_t$  assuming that the process is in-control state: the first one is the intercept  $a_i$  control chart which is similar to arcsin EWMA Sign control chart [32]. This control chart tests the null hypothesis that mean is equal to mean  $(\sin^{-1}\sqrt{p_0})$  at time t; the second control chart is for slop  $b_i$  that is used to test the null hypothesis  $b_i=0$  at time t against the alternative hypothesis  $b_i\neq 0$ ; and the third one is a linear prediction based proposed control chart  $F_t$  that used to test the IC process. This control chart used to test the null hypothesis  $F_t=\mu_0=\sin^{-1}\sqrt{p_0}$  at time t.

1) A NONPARAMETRIC RSDEWMA CONTROL CHART FOR INTERCEPT  $(a_i)$ 

The expected value and variance of intercept of linear prediction  $a_i$  as below: detail see in Appendix A, A.1.

$$E(a_i) = \sin^{-1} \sqrt{p_0} \tag{11}$$

The asymptotic variance for the intercept  $a_i$  for the large value of i proposed by [38] written as: see the detail in Appendix A. A.1

$$Var_{asym}(a_i) = \frac{\lambda(1 + 4(1 - \lambda) + 5(1 - \lambda)^2)}{(1 + (1 - \lambda))^2(4n)}$$
(12)

Hence, the repetitive sampling control limits for the intercept  $a_i$  control chart became:

$$UCL_1/LCL_1 = \sin^{-1}\sqrt{p_0} \pm k_1 \sqrt{\frac{\lambda(1+4(1-\lambda)+5(1-\lambda)^2)}{(1+(1-\lambda))^2(4n)}}$$
(13)

$$CL = \sin^{-1} \sqrt{p_0}$$

$$UCL_2/LCL_2 = \sin^{-1} \sqrt{p_0} \pm k_2 \sqrt{\frac{\lambda(1+4(1-\lambda)+5(1-\lambda)^2)}{(1+(1-\lambda))^2(4n)}}$$
(14)

## 2) A NONPARAMETRIC RSDEWMA CONTROL CHART FOR SLOPE $(b_i)$

The mean and variance of slop  $b_i$  by using the expected value of  $Z_i$  and  $Z'_i$  are given by;

$$E(b_i) = 0 (15)$$

The asymptotic variance of slop  $b_i$  showed Brown [38] and detail are explained in Appendix A. A.4.:

$$Var_{asym}(b_i) = \frac{2\lambda^3}{(1 + (1 - \lambda))^3 (4n)}$$
 (16)

Then, the limits for the  $b_i$  chart using repetitive sampling become:

$$UCL_1/LCL_1 = \pm k_1 \sqrt{\frac{2\lambda^3}{(1 + (1 - \lambda))^3 (4n)}}$$
 (17)

$$CL = 0$$

$$UCL_2/LCL_2 = \pm k_2 \sqrt{\frac{2\lambda^3}{(1 + (1 - \lambda))^3 (4n)}}$$
(18)

3) THE PROPOSED RSNPDEBLP CONTROL CHART FOR  $F_t$  The expected value of linear prediction  $F_t$  is given by: detail can be seen in Appendix B. B1.

$$E(F_{i+t}) = \sin^{-1} \sqrt{p_0}$$
 (19)

The asymptotic Variance of  $F_t$  is given by: detail see in Appendix B. B.2.

$$Var_{asym}(F_t) = \frac{1}{4n} \left( \frac{\lambda(1+4(1-\lambda)+5(1-\lambda)^2)}{(1+(1-\lambda))^2} + \frac{2\lambda^3}{(1+(1-\lambda))^3} + \frac{\lambda^2(1+3(1-\lambda))}{(1+(1-\lambda))^3} \right)$$
(20)



The asymptotic control limits of nonparametric linear prediction based DEWMA sign control chart designed for repetitive sampling are written as:

$$UCL_1/LCL_1 = \sin^{-1}\sqrt{p_0} \pm k_1\sqrt{(Var_{asym}(F_t))}$$
 (21)  

$$CL = \sin^{-1}\sqrt{p_0}$$

$$UCL_2/LCL_2 = \sin^{-1}\sqrt{p_0} \pm k_2\sqrt{(Var_{asym}(F_t))}$$
 (22)

where  $k_1$  and  $k_2$  ( $k_1 > k_2$ ) are the control coefficient, which directly affect the width of the control limits. The values of control chart coefficient  $k_1$  and  $k_2$  depends on the values of n,  $\lambda$  and  $ARL_0$  for the RSNPASDEBLP control chart which gives the minimum values of  $ARL_1$ . The procedure is asserted to be IC if any  $LCL_2 \leq F_t \geq UCL_2$ . If  $UCL_2 \leq F_t < UCL_1$  or  $LCL_1 < F_t \leq LCL_2$  then repeat the process.

### D. DESIGN OF A RSNPDEBLP CONTROL CHART $F_t$

The designed control chart RSNPDEBLP are calculated by using the different values of  $k_1$ ,  $k_2$ , n,  $p_0$  and smooth parameter  $\lambda$ . It is possible to select all the factors values for a certain number to give the mean presentation of IC ARL in the null hypothesis. For example, an  $ARL_0 = 370$  is the equivalent of average run length of Shewhart control chart under the null hypothesis  $H_0$  for  $3\sigma$  as its control limits. The RSNPDEBLP can be designed to obtain the  $ARL_0 = 370$ , 500 by using the different values of  $k_1$ ,  $k_2$ , n and  $\lambda$ . The ARL is a common scale that used to rate the proficiency of the control chart. Therefore, for calculating the  $ARL_0$  values and the first point to be out of control the following Algorithm is used.

### **III. RESULTS AND DISCUSSION**

Tables 1 and 2 represent the ARLs and SDRL for different values of control constants, n,  $\lambda$  when  $r_0 = 370, 500$ . The ARLs are very sensitive to chosen the pair of control limits coefficients, so that's why must be selected carefully. During the simulation, it is noted that several combinations of control limits coefficients ( $k_1$  and  $k_2$ ) exist which give the specified values of  $ARL_0$ . But, we just use the combination of control limits coefficients which give the minimum values of  $ARL_1$ for a specific design shift under the restriction of  $ARL_0 =$ 370, 500 and  $k_1 > k_2$ . The values of control constants  $k_1$  and  $k_2$  calculated for the proposed chart are shown in Table 1 and 2 for various values of  $\lambda$  and n. While, the selected values of control constants, smoothing parameters  $\lambda$ , and sample size n have shown that the planned control chart provided small ARLs for all  $p_1$ . Moreover, the RSNPDEBLP control chart gives smaller OOC ARL values when  $\lambda$  is smaller (e.g. 0.05, 0.10, 0.20, 0.25, 0.40). From both tables, the following trends of OOC ARL values have been noted:

- When  $p_0 = 0.5$ , the ARL is close to specified  $r_0$ .
- For specified values of  $p_1$ , the values of OOC  $ARL_1$  increase as the  $\lambda$  increase and  $ARL_1$  values reduce as the sample size n increase. But  $ARL_1$  values reduce speedily as the shift  $p_1$  and  $\lambda$  values increase.
- For other specified values, the ARL<sub>1</sub> values also decrease as the value of r<sub>0</sub> increase. For example,

**Algorithm** R Program for IC and OOC Procedure of RSNPDEBLP Control Chart by Using Monte Carlo Simulation

- (1) Computation of the NPASDE statistics  $Z'_i$  and  $F_t$ .
- (1.1) Fix the values of sample size (n), smoothing constant  $\lambda$ , and the value of IC ARL, say  $r_0$ .
- (1.2) Calculating a random number  $M_i$  and  $Y_i$  from the Binomial Distribution having n and  $p_0 = 0.5$ .
- (1.3) Calculate the  $Z_i$  for  $i^{th}$  subgroup.
- (1.4) Compute the NPASDE  $Z_i'$  for  $i^{th}$  subgroup.
- (1.5) Calculate the  $a_i$ ,  $b_i$  and  $F_t$  for  $i^{th}$  subgroup.
- (2) Compute the control limits ( $LCL_1$ ,  $LCL_2$ ,  $UCL_1$  and  $UCL_2$ ) using randomly selected values of  $k_1$  and  $k_2$ .
- (2.1) Based on 100,000 repetitions, get various combinations of  $\lambda$ , n, and limit coefficients  $k_1$  and  $k_2$  for which  $ARL_0 = 370, 500$ .
- (2.2) Select a pair of limit coefficients from step 2.1 for which OOC  $ARL_1$  is minimum for a specific shift  $(p_1)$ .
- (2.3) Declare the process as OOC if  $F_t > UCL_1$  or  $F_t < LCL_1$ . The procedure is asserted to be IC if any  $LCL_2 \le F_t \ge UCL_2$ . If  $UCL_2 \le F_t < UCL_1$  or  $LCL_1 < F_t \le LCL_2$ , go to Step 1 and repeat the process.
- (2.4) If the procedure is IC, repeat the Steps 1 to 2.3. If the process is asserted OOC, then record the subgroup's number as the IC ARL. If IC ARL is equal to the fix  $ARL_0$  value, then move to Step 3 with recorded values of coefficients  $k_1$  and  $k_2$ . Otherwise, modify the values of coefficients and repeat Step 2.
- (3) Evaluating the OOC ARL.
- (3.1) Generate a random number  $M_i$ , and  $Y_i$  for the  $i^{th}$  subgroup from the binomial distribution with parameters n and  $p = p_1 \neq 0.5$  considering a shift.
- (3.2) Compute the  $Z_i$ ,  $Z'_i$  and  $F_t$  for the  $i^{th}$  subgroup.
- (3.3) Repeat the Steps 3.1 and 3.2 until the process is declared as OOC. Count the number of subgroups as an OOC run length.
  - when  $r_0 = 370$ ,  $\lambda = 0.05$ , n = 5 and  $p_1 = 0.70$  the value of  $ARL_1 = 4.06$ , while the value of  $ARL_1 = 3.47$  when  $r_0 = 500$ .
- The new control chart is more efficient to detect small shifts in the process, increases as the value of  $\lambda$  decreases. For example, when  $\lambda = 0.20$ , n = 5,  $p_1 = 0.55$ ,  $ARL_1 = 243.19$  and when  $\lambda = 0.05$ , n = 5,  $p_1 = 0.55$ ,  $ARL_1 = 112.72$ .
- The ARL and SDRL values decreases when the level of  $p_1$  increases, considering the fixed values of  $\lambda$  and n.
- We also note that a large shift in the process is identified more quickly when  $\lambda$  is large and small shift is identified more quickly when  $\lambda$  is small. For instance, when  $r_0 = 370$ ,  $\lambda = 0.05$ , n = 5, and  $p_1 = 0.55$ , the value of OOC ARL is 112.72, and the value of OOC ARL is 243.19 when  $\lambda = 0.20$ , but when  $p_1 = 0.90$  with the same values of all



**TABLE 1.** The ARL and SDRL values of the proposed chart for Different Values of n and  $\lambda$  when  $r_0 = 370$ .

$\lambda$	n		$k_1$	$k_2$					n <sub>1</sub>				
_ ^	11		10.1	102	0.50	0.55	0.60	0.65	$\frac{p_1}{0.70}$	0.75	0.80	0.90	0.95
0.05	5	ARL	2.62	0.93	370.92	112.72	18.02	8.05	4.06	3.37	2.53	1.64	1.29
0.05		SDRL	2.02	0.55	362.24	104.94	15.01	5.10	2.84	1.91	1.33	0.83	0.62
	10	ARL	2.21	0.84	370.01	39.21	8.62	4.77	3.07	2.29	2.08	1.74	1.46
		SDRL			422.07	42.85	5.80	2.56	1.32	0.82	0.54	0.44	0.55
	15	ARL	2.18	0.63	370.71	20.59	5.39	2.57	2.04	1.66	1.44	1.03	1.01
		SDRL			426.97	19.47	2.82	1.51	0.85	0.85	0.55	0.17	0.10
	20	ARL	2.09	0.86	370.78	17.04	5.11	3.13	2.49	2.02	1.54	1.05	1.00
		SDRL			407.49	12.67	2.91	1.41	1.08	0.71	0.53	0.22	0.00
	25	ARL	2.06	0.93	370.14	15.74	4.60	2.96	2.28	1.85	1.57	1.13	1.01
		SDRL			421.72	11.92	2.27	1.23	0.73	0.61	0.49	0.34	0.10
0.10	5	ARL	2.83	1.92	370.23	157.02	31.38	12.27	4.36	3.00	2.05	1.50	1.30
		SDRL			353.73	155.50	26.63	11.55	3.00	1.92	1.05	0.64	0.48
	10	ARL	2.46	0.72	371.69	83.47	9.76	3.41	2.38	1.76	1.42	1.11	1.02
		SDRL			329.01	88.71	9.12	2.41	1.45	0.86	0.63	0.31	0.14
	15	ARL	2.26	1.29	370.64	57.67	10.80	4.06	3.15	2.32	2.00	1.43	1.12
		SDRL			381.13	47.22	8.94	2.15	1.36	0.75	0.56	0.51	0.32
	20	ARL	2.18	1.58	370.44	43.53	8.80	4.78	3.03	2.43	1.84	1.39	1.06
		SDRL			394.54	48.44	6.06	2.46	1.02	0.75	0.54	0.51	0.23
	25	ARL	2.18	1.22	370.63	29.83	5.60	2.93	2.11	1.68	1.38	1.06	1.00
0.45	_	SDRL			379.18	27.48	3.85	1.31	0.77	0.65	0.54	0.23	0.00
0.15	5	ARL	3.14	0.90	371.65	191.59	52.50	13.92	5.00	2.85	2.14	1.41	1.22
	10	SDRL	2.64	0.02	394.15	175.11	52.87	14.93	4.13	1.76	1.07	0.55	0.44
	10	ARL	2.64	0.83	371.42 389.15	134.32 132.92	23.04 24.51	3.99	2.11	1.90 0.98	1.41	1.08	1.01 0.10
	15	SDRL ARL	2.47	0.90	370.72	84.73	9.28	2.88 3.00	1.00 1.85	1.47	0.60 1.18	0.27 1.00	1.00
	13	SDRL	2.47	0.90	352.95	82.76	7.33	2.38	0.93	0.70	0.41	0.00	0.00
	20	ARL	2.39	0.91	370.50	37.49	5.35	1.99	1.58	1.28	1.05	1.01	1.00
	20	SDRL	2.39	0.91	376.64	33.42	4.38	1.26	0.75	0.56	0.22	0.10	0.00
	25	ARL	2.49	0.52	370.04	31.10	2.61	1.57	1.13	1.07	1.00	1.00	1.00
	20	SDRL	2.17	0.52	335.28	32.10	1.66	0.70	0.36	0.25	0.00	0.00	0.00
0.20	5	ARL	3.26	1.40	370.39	243.19	86.03	31.14	11.01	5.54	2.70	1.62	1.22
0.20		SDRL	0.20	11110	399.76	209.12	90.77	34.39	11.41	5.01	1.87	0.70	0.46
	10	ARL	2.96	0.70	370.73	174.25	37.02	7.11	2.17	1.27	1.09	1.02	1.00
		SDRL			337.00	163.94	35.89	6.75	1.62	0.52	0.28	0.14	0.00
	15	ARL	2.75	0.54	371.34	101.30	11.66	2.43	1.41	1.27	1.07	1.00	1.00
		SDRL			330.64	107.56	12.88	1.81	0.71	0.51	0.29	0.00	0.00
	20	ARL	2.52	0.81	371.72	66.59	7.35	2.24	1.43	1.29	1.16	1.02	1.00
		SDRL			385.17	61.62	6.43	1.40	0.62	0.53	0.36	0.14	0.00
	25	ARL	2.49	0.79	370.85	47.45	4.44	1.69	1.22	1.08	1.01	1.00	1.00
		SDRL			382.15	46.24	4.34	0.95	0.50	0.27	0.10	0.00	0.00
0.25	5	ARL	3.42	1.67	370.51	291.31	127.46	40.59	19.06	8.87	4.12	1.60	1.23
	10	SDRL	2.02	1.70	384.01	282.85	112.07	46.90	19.63	11.11	3.37	0.89	0.48
	10	ARL	2.82	1.78	370.38	236.27	60.76	22.11	6.94	3.20	2.21	1.37	1.04
	15	SDRL ARL	2.73	0.84	406.61 370.52	255.36 152.40	71.55 19.03	21.16 4.46	7.62 1.59	2.05 1.22	1.04 1.03	0.52 1.00	0.19 1.00
	13	SDRL	2.13	0.64	348.96	158.16	18.05	4.46	0.91	0.52	0.17	0.00	0.10
	20	ARL	2.64	0.72	370.69	84.65	8.51	2.14	1.31	1.18	1.04	1.00	1.00
	20	SDRL	2.07	0.72	362.60	89.45	7.99	1.38	0.61	0.43	0.19	0.00	0.00
	25	ARL	2.60	0.85	370.83	76.76	7.37	1.70	1.34	1.05	1.03	1.00	1.00
	23	SDRL	2.00	0.05	357.08	70.99	7.39	1.07	0.55	0.21	0.17	0.00	0.00
0.40	5	ARL	3.65	1.39	371.50	290.27	109.09	56.46	32.20	10.79	5.76	1.55	1.24
	-	SDRL	- 100		368.02	302.91	110.06	75.82	31.88	9.94	5.83	0.78	0.53
	10	ARL	3.74	0.93	369.69	248.01	102.63	33.71	12.48	3.41	1.70	1.00	1.00
	-	SDRL			396.18	233.04	96.83	31.23	12.01	3.16	1.19	0.00	0.00
	15	ARL	3.12	0.78	369.88	186.91	58.06	13.35	2.99	1.44	1.07	1.00	1.00
		SDRL			364.82	183.46	55.54	15.15	2.68	0.79	0.25	0.00	0.00
	20	ARL	3.03	0.71	371.44	164.78	27.16	5.12	1.72	1.13	1.01	1.00	1.00
		SDRL			365.48	161.68	26.62	4.95	1.35	0.39	0.10	0.00	0.00
	25	ARL	2.92	0.81	370.53	123.37	17.75	3.19	1.24	1.04	1.01	1.00	1.00
		SDRL			344.04	112.24	17.63	3.36	0.62	0.19	0.10	0.00	0.00

parameters the OOC ARL for  $\lambda = 0.05$  is 1.64 and the value of OOC ARL is 1.62 when  $\lambda = 0.20$  (Ref. Table 1). The same trend we can see in the Table 2, when  $r_0 = 500$ ,  $\lambda = 0.05$ , n = 5, and  $p_1 = 0.55$ , the OOC ARL value is 231.16 and OOC ARL value is 277.27 when  $\lambda = 0.20$ , but when  $p_1 = 0.90$  with

the same other parameters values the OOC ARL is 1.48 for  $\lambda=0.05$  and it is 1.42 when  $\lambda=0.20$ .

From tables 1 and 2, it has been noted that if the value of  $r_0$  is large, the reducing trend of  $ARL_1$  is also increased. Such as, when  $r_0 = 370$  and  $\lambda = 0.05$ , n = 5, the value of OOC ARL decreased



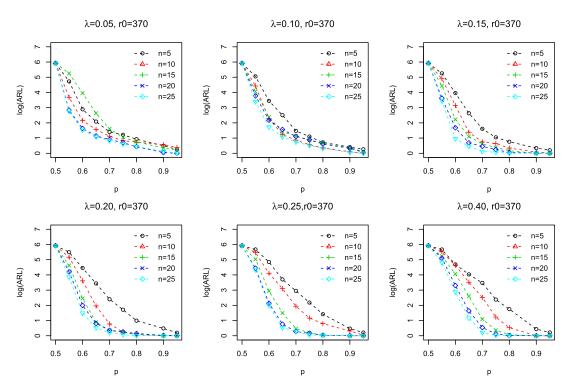


FIGURE 1. ARL comparison of the RSNPDBLP chart for different values of  $\lambda$  and n at ARL<sub>0</sub> = 370.

31.30% to  $ARL_0$  value for  $p_1 = 0.55$  and 2.18%for  $p_1 = 0.65$ . With the same sample size n,  $ARL_0$ values, and different value of  $\lambda = 0.20$ , the value of ARL1 decreased 65.64% for  $p_1 = 0.55$  and 8.41% for  $p_1 = 0.65$ . While, when sample size and fixed IC ARL are the same but  $\lambda = 0.25$ , the value of  $ARL_1$  decreased 78.6% for  $p_1 = 0.55$  and 10.9% for  $p_1 = 0.65$ . On the other hand, when  $r_0$  value is increased, for example, when  $r_0 = 500$  and smoothing constant same like as  $\lambda = 0.05$  and n = 5, the value of  $ARL_1$  decrease 45.2% to IC ARLfor  $p_1 = 0.55$  and 1.06% for  $p_1 = 0.65$ , when same  $r_0$ , and n but different value of  $\lambda = 0.20$  the ARL<sub>1</sub> value decrease 55.41% to  $ARL_0$  for  $p_1 = 0.55$  and 6.52% for  $p_1 = 0.65$ . However, with the same value of ARL<sub>0</sub> and sample size but the different value of  $\lambda = 0.25$ , the value of OOC ARL decrease 62.72% to IC ARL for  $p_1 = 0.55$  and 10.5% for  $p_0 = 0.65$ .

Consequently, as slope  $p_1$  values arises in the process proportion at pre-specified values of  $r_0 = 370, 500$ , the  $ARL_1$  values performance shows the decreasing trend. It is also noted that when sample size increases the  $ARL_1s$  values decreases rapidly, specially for smaller shifts. For example, in table 1 when  $r_0 = 370, \lambda = 0.05$  and slope  $(p_1)$  is 0.60 observed that  $ARL_1 = (18.02, 8.62, 5.39, 5.11, 4.60)$  values have shown a decreasing trend when n = (5, 10, 15, 20, 25) values are increasing. Similarly, when  $\lambda = 0.25$  but sample size and slope values are the same the values of  $ARL_1$  were (127.46,60.76,19.03, 8.51,7.37). It also shows the

decreasing trend in OOC ARL when n are increased. In Table 2, the ARLs values of the proposed control chart are calculated, when  $r_0 = 500$ ,  $\lambda = 0.05$ , 0.10, 0.20, 0.25, 0.40 and n = 5, 10, 15, 20, 25. This also shows the decreasing trend in OOC ARL at different  $\lambda$  and sample size values. A comparison between the ARL values of the planned control chart is revealed in Figures 1 and 2 for identified values of  $r_0 = 370$ , 500. From these graphs, it is identified that ARLs values for the proposed control chart RSNPDEBLP are relatively smaller at every value of the shifted parameter  $p_1$ .

## IV. COMPARISON OF PROPOSED CONTROL CHART RSNPDEBLP ARLS WITH DIFFERENT EXISTING CONTROL CHARTS

In this section, the efficiency of the RSNPDEBLP control chart with the existing control charts NPSE and NPASE proposed by [32], newly designed control chart NPASDE, NPASME presented by [33], and RSNPSE control chart introduced by [22] are discussed. The efficiency of the new control chart is calculated in positions of ARL with the existing control charts. For example, when n=20,  $\lambda=0.05$  and  $p_1=0.60$  the value of proposed chart  $ARL_1$  is 5.11, while the  $ARL_1$  value of NPSE is 12.43, NPASE is 12.24, NPASDE is 18.52, NPASME is 12.41 and RSNPSE is 10.44.

## A. RSNPDEBLP CONTROL CHART VERSUS NPSE AND NPASE CONTROL CHART

This section describes the explanation of the advantages of newly developed RSNPDEBLP control chart as competed to



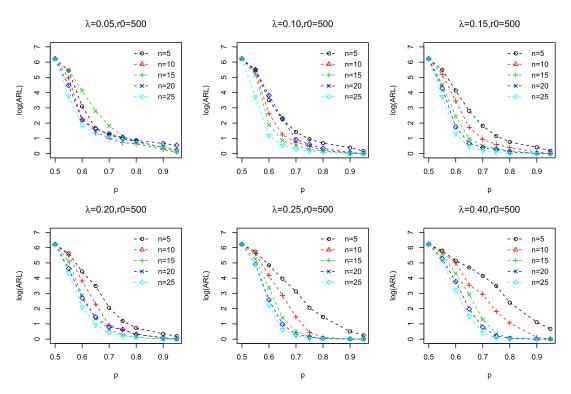
**TABLE 2.** The ARL and SDRL values of the proposed chart for Different Values of n and  $\lambda$  when  $r_0 = 500$ .

O.D.   C.D.   O.D.				I <sub>a</sub>	10	I								
0.05   S	$\lambda$	n		$k_1$	$k_2$	0.50	0.55	0.60	0.65	0.70	0.75	0.80	0.00	0.05
SDRL   ARL   2.86   0.82   500.76   143.65   9.37   4.10   2.69   2.05   1.58   1.08   0.64   0.49	0.05	5	ADI	3.20	0.71									
10	0.05	3		3.20	0.71									
SORL   SORL   SORD		10		2.86	0.82									
15		10		2.00	0.02									
SDRL		15		2.81	1 39									
20		13	1	2.01	1.59									
SDRL		20	1	2.78	1 44									
25		20		2.70	1									
SDRL		25		2.76	1.26									
10		23		2.70	1.20									
SDRL	0.10	5	1	3.11	0.82									
10	0.10			5.11	5.62									
SDRL		10		2.92	0.61									
15														
SDRL		15	1	2.82	0.71									
20														
SDRL   C		20		2.84	0.84	500.07								1.00
0.15			1											
SDRL		25	ARL	2.72	0.65	499.87								1.00
10	0.15	5	ARL	3.23	0.97	501.22	242.51	62.51	16.37	6.15	3.17	2.15	1.51	1.20
SDRL			SDRL			499.49	238.38	59.19	16.32	5.21	2.45	1.18	0.63	0.40
15		10	ARL	2.82	0.90	500.88	178.32	31.37	5.59	2.54	1.83	1.47	1.11	1.00
SDRL			SDRL			450.62	178.48	31.43	4.52	1.62	0.91	0.72	0.31	0.00
20		15	ARL	2.69	0.69	499.69	91.78	11.47	2.65	1.66	1.36	1.20	1.02	1.00
SDRL			SDRL			472.97			1.57	0.76	0.55	0.45	0.14	0.00
25		20	ARL	2.59	0.73	501.51	72.57	5.78	1.96	1.49	1.33	1.12	1.01	1.00
0.20			SDRL			455.98	70.18	4.98	0.99	0.61	0.58	0.35	0.10	0.00
0.20   5		25	ARL	2.52	0.67		41.85	3.61	1.57	1.18	1.07	1.00	1.00	
SDRL			1											
10	0.20	5		3.51	0.83									
SDRL   SDRL   Color   Color														
15		10		3.10	0.80									
SDRL   Color   Color														
20		15		2.70	0.92									
SDRL		20		2.52	1 45									
25		20	1	2.52	1.45									
0.25         5         ARL SDRL ARL SDRL         3.52 3.52         1.55 1.55         496.17 500.93         74.02 312.96         7.85 126.64         1.37 52.72         0.73 22.86         0.48 7.86         0.31 4.29         0.00 1.66         1.28 1.28           0.25         ARL SDRL         3.52         1.55         500.93 490.66         292.17 292.17         128.00 292.17         506.89 29.14         29.14 7.87         7.87 3.87         3.87 0.94         0.94 0.55           10         ARL SDRL         3.26         0.79 501.63         190.52 190.52         29.12 29.12         4.07 4.07         1.66 1.18         1.08 1.07         0.38 0.27         0.00 0.00         1.00 0.00           20         ARL SDRL         2.87 302         0.68 303.67         136.64 142.55         14.69 14.69 14.69 14.69 14.69 14.69 14.80 30.31         1.00 1.00 1.00 1.00         1.00 1.00 1.00           25         ARL SDRL         2.91 2.91 2.91 3.84 3.86         2.01 3.03.17         135.84 4.92 4.83.19         9.24 4.85 1.85 1.30         1.04 1.02 1.00 1.00 1.00         1.00 1.00 1.00         1.00 1.00 1.00           0.40         5         ARL 3.86 3.86 3.86 3.86 3.86 3.86 3.86 3.86		25	1	2.50	1.26									
0.25         5         ARL SDRL         3.52 3.26         1.55 490.66         500.93 490.66         312.96 292.17         126.64 56.89         52.72 29.14         22.86 7.87         7.86 3.87         4.29 0.94         1.66 0.55         1.28 0.94         0.55           10         ARL SDRL         3.26 401.51         0.79 501.63         501.57 190.52         271.29 255.74         60.03 60.03         17.06 17.06         3.87 3.87         1.07 1.07         0.38 0.14         0.00 0.38         0.14 0.00         0.00 0.00           15         ARL SDRL         2.90 2.97         0.79 501.63         190.52 190.52         29.12 29.12         4.07 4.07         1.66 1.18         1.18 1.08         1.00 1.00         1.00 0.00           20         ARL SDRL         2.87 2.91         0.68 2.87         503.67 136.64         13.13 2.65 144.95         2.46 1.85 1.30         1.04 1.02         1.03 1.00         1.00 1.00           25         ARL SDRL         2.91 483.19         0.72 148.80         503.17 148.80         13.58 8, 79 1.02         0.55 0.19 0.55         0.19 0.14         0.00 0.00         0.00 0.00           0.40         5         ARL SDRL         3.86 3.66         2.01 3.07         500.10 332.53         172.27 109.77         63.36 3.279         10.96 3.03 3.03         3.03 1.97         1.01 43.10		23	1	2.30	1.20				1					
SDRL   ARL   3.26   0.79   501.57   271.29   64.86   17.67   4.28   1.57   1.12   1.02   1.00	0.25	5		2 52	1.55									
10	0.23	3		3.32	1.55									
SDRL		10		3.26	0.79									
15 ARL SDRL 2.90 0.79 501.63 190.52 29.12 4.07 1.66 1.18 1.08 1.00 1.00   SDRL 2.87 0.68 503.67 136.64 13.13 2.65 1.36 1.15 1.03 1.00 1.00   SDRL 2.5 ARL 2.91 0.72 503.17 135.84 9.24 1.85 1.30 1.04 1.02 1.00 1.00   SDRL 483.19 148.80 8.79 1.02 0.55 0.19 0.14 0.00 0.00   SDRL 5DRL 457.19 343.26 181.62 111.66 74.56 37.59 14.14 4.32 5.18   SDRL 10 ARL 3.66 1.37 500.78 300.71 148.65 34.38 19.02 6.08 2.88 1.12 1.01 SDRL 15 ARL 3.16 0.99 501.95 266.79 74.64 18.65 3.60 1.42 1.08 1.00 1.00 1.00 SDRL 20 ARL 3.06 0.98 500.96 197.50 43.69 7.18 2.19 1.22 1.06 1.00 0.00 0.00 25 ARL 3.03 0.91 501.09 171.11 24.47 4.55 1.54 1.05 1.01 1.00 1.00 0.00 0.00 25 ARL 3.03 0.91 501.09 171.11 24.47 4.55 1.54 1.05 1.01 1.00 1.00 1.00 0.00 0.00 0.00		10	1	3.20	0.75									
SDRL   2.87   0.68   503.67   136.64   13.13   2.65   1.36   1.15   1.03   1.00   1.00		15	1	2.90	0.79									
20		1.5	1	2.70	0.75									
SDRL   2.91   0.72   503.17   135.84   9.24   1.85   1.30   1.04   1.02   1.00   1.00		20		2.87	0.68									
0.40         5         ARL SDRL         2.91         0.72         503.17 135.84 9.24 1.85 1.30 1.04 1.02 1.00 1.00 1.00 1.00 1.00 1.00 1.00														
0.40         SDRL SDRL         3.86         2.01         483.19 500.10         332.53 32.53         172.27 109.77		25	1	2.91	0.72									
0.40         5         ARL SDRL         3.86         2.01         500.10         332.53         172.27         109.77         63.36         32.79         10.96         3.03         1.97           SDRL         3.66         1.37         500.78         300.71         148.65         34.38         19.02         6.08         2.88         1.12         1.01           SDRL         552.43         280.86         131.98         31.84         17.36         7.17         3.13         0.35         0.10           SDRL         3.16         0.99         501.95         266.79         74.64         18.65         3.60         1.42         1.08         1.00         1.00           SDRL         496.37         2.82.58         65.78         17.45         4.15         0.82         0.34         0.00         0.00           20         ARL         3.06         0.98         500.96         197.50         43.69         7.18         2.19         1.22         1.06         1.00         1.00           SDRL         481.73         194.84         47.74         6.69         2.09         0.56         0.24         0.00         0.00           25         ARL         3.03         <														
SDRL   ARL   3.66   1.37   500.78   300.71   148.65   34.38   19.02   6.08   2.88   1.12   1.01	0.40	5		3.86	2.01									
10 ARL SDRL SDRL SDRL SDRL SDRL SDRL SDRL SD														
15 ARL SDRL SDRL 20 ARL SDRL 3.06 0.98 500.96 197.50 43.69 7.18 2.19 1.22 1.06 1.00 1.00 1.00 SDRL 25 ARL 3.03 0.91 501.09 171.11 24.47 4.55 1.54 1.05 1.01 1.00 1.00 1.00		10	ARL	3.66	1.37		300.71	148.65	34.38	19.02		2.88		1.01
SDRL 20 ARL 3.06 0.98 500.96 197.50 43.69 7.18 2.19 1.22 1.06 1.00 1.00 SDRL 25 ARL 3.03 0.91 501.09 171.11 24.47 4.55 1.54 1.05 1.01 1.00 1.00			SDRL					131.98	31.84	17.36	7.17	3.13	0.35	0.10
20     ARL     3.06     0.98     500.96     197.50     43.69     7.18     2.19     1.22     1.06     1.00     1.00       SDRL     481.73     194.84     47.74     6.69     2.09     0.56     0.24     0.00     0.00       25     ARL     3.03     0.91     501.09     171.11     24.47     4.55     1.54     1.05     1.01     1.00     1.00		15		3.16	0.99	501.95			18.65	3.60	1.42	1.08	1.00	1.00
SDRL   481.73   194.84   47.74   6.69   2.09   0.56   0.24   0.00   0.											0.82	0.34	0.00	
25   ARL   3.03   0.91   501.09   171.11   24.47   4.55   1.54   1.05   1.01   1.00   1.00		20		3.06	0.98									
SDRL   435.17   1.62.59   24.55   4.92   0.79   0.22   0.10   0.00   0.00		25		3.03	0.91									
			SDRL			435.17	1.62.59	24.55	4.92	0.79	0.22	0.10	0.00	0.00

the NPSE and NPASE control charts. The calculated average run length values for the usual control chart when  $r_0 = 370$ ,  $\lambda = 0.05$ , 0.10, 0.25 and n = 10, 15, 20 are given in Table 3. The computed values of ARL have shown that for the new control chart OOC ARL values are smaller at all values of  $p_1$  as competed to existing control charts. For Example, when  $p_1 = 0.60$ ,  $\lambda = 0.05$  and n = 10 the value of  $ARL_1$ 

for the proposed control chart is 8.62, while the existing control charts  $ARL_1$  are 19.08 and 19.09. This presented the efficiency of the new control chart because it detects a reduced trend in the procedure as equated to the NPSE and NPASE control charts [32]. Same as, we can see that when  $\lambda$  value is same but n=20 increase, the proposed chart OOC ARL is 5.11 and the existing charts' OOC ARL values are





**FIGURE 2.** ARL comparison of the RSNPDBLP chart for different values of  $\lambda$  and n at ARL<sub>0</sub> = 500.

TABLE 3. Comparison Between proposed RSNPDEBLP and Existing NPSE, NPASE, NPASME, NPASDE control charts for Different Values of Slope  $(p_1)$ ,  $\lambda$  and n when  $ARL_0 = 370$ .

	$p_1$										
Control Chart (Coefficient)	0.50	0.55	0.60	0.65	0.70	0.75	0.80	0.90	0.95		
		$\lambda = 0.05, n = 10$									
NPSE(k=2.50)	382.41	51.59	19.08	11.45	8.10	6.34	5.21	3.91	3.44		
NPASE(k=2.67)	371.23	52.05	19.09	11.28	7.93	5.99	4.78	3.26	2.71		
NPASDE(k=2.00)	372.07	52.34	24.99	17.58	14.18	12.11	10.58	8.31	7.44		
NPASME(k = 2.595)	370.62	52.36	19.22	11.47	8.17	6.29	5.12	3.67	3.20		
$RSNPSE(k_1 = 2.69, k_2 = 0.87)$	373.46	33.08	14.65	9.75	6.78	5.54	4.45	3.67	3.02		
$RSNPASDEBLP(k_1 = 2.21, k_2 = 0.84)$	370.01	39.21	8.62	4.77	3.07	2.29	2.08	1.74	1.46		
				$\lambda =$	= 0.05, n =	20					
NPSE(k=2.51)	385.68	31.42	12.43	7.69	5.62	4.43	3.69	2.93	2.61		
NPASE(k=2.56)	374.53	31.11	12.24	7.46	5.40	4.19	3.43	2.44	2.08		
NPASDE(k=1.93)	374.63	34.46	18.52	13.67	11.41	9.88	8.74	6.93	6.16		
NPASME(k=2.495)	370.87	31.17	12.41	7.73	5.71	4.57	3.83	2.88	2.50		
$RSNPSE(k_1 = 2.84, k_2 = 0.56)$	370.16	22.80	10.44	6.22	5.72	4.37	3.17	2.00	2.00		
RSNPASDEBLP( $k_1 = 2.09, k_2 = 0.86$ )	370.78	17.04	5.11	3.13	2.49	2.02	1.54	1.05	1.00		
	$\lambda = 0.10, n = 15$										
NPSE(k=2.70)	374.06	43.46	13.99	7.91	5.54	4.27	3.49	2.59	2.18		
NPASE(k=2.82)	378.47	43.97	14.02	7.87	5.41	4.14	3.32	2.34	2.05		
NPASDE(k=2.30)	373.09	39.75	15.85	10.93	8.68	7.35	6.37	4.99	4.37		
NPASME(k=2.722)	370.37	45.85	13.99	8.02	5.64	4.39	3.61	2.75	2.35		
$RSNPSE(k_1 = 2.19, k_2 = 0.71)$	370.46	44.12	11.55	6.75	4.96	3.60	3.35	2.05	2.00		
RSNPASDEBLP( $k_1 = 2.33, k_2 = 0.94$ )	370.92	43.62	3.45	2.07	1.14	1.21	1.18	1.01	1.00		
	$\lambda = 0.25, n = 20$										
NPSE(k=2.89)	377.58	50.54	12.38	6.12	3.92	2.92	2.36	1.89	1.64		
NPASE(k=3.00)	375.87	52.55	12.80	6.10	3.91	2.89	2.31	1.61	1.25		
NPASDE(k=2.73)	378.21	99.31	11.46	6.58	4.85	3.96	3.39	2.70	2.26		
NPASME(k=2.914)	371.36	110.45	21.28	10.19	6.08	3.12	2.56	2.03	2.00		
$RSNPSE(k_1 = 2.37, k_2 = 0.83)$	374.91	100.17	27.65	13.31	5.18	3.76	2.39	2.04	2.00		
RSNPASDEBLP $(k_1 = 2.64, k_2 = 0.72)$	370.69	84.65	8.51	2.04	1.31	1.18	1.04	1.00	1.00		

12.43 and 12.24. Which are larger than the proposed chart OOC ARL values. Another comparison of the proposed and

the existing chart can be seen in table 3 with different values of  $\lambda$  and n that show the efficiency of the new chart too.



### B. RSNPDEBLP CONTROL CHART VERSUS NPASDE CONTROL CHARTS

This section shows the comparison between the implementation of the RSNPDEBLP control chart over the existing non-parametric DEWMA control chart (NPASDE). For different values of  $\lambda$  and n the proposed control chart has smallest values at every values of  $p_1$  in contrast of NPASDE control chart. The ARL values of NPASDE and RSNPDEBLP control chart for the specified value of  $r_0 = 370$  are given in Table 3, that shows the OOC  $ARL_1$  values of the RSNPDEBLP are lesser at all value of the shift. For example, when  $\lambda = 0.05$ , n = 10, and  $p_1 = 0.60$ , the  $ARL_1$  value for the newly developed control chart is 8.62, while 24.99 for the NPASDE control chart. Other than that, we can also see the efficiency of the proposed chart when  $\lambda$  and n are increased. For example, when  $\lambda = 0.10$  and n = 15, the proposed chart  $ARL_1$  is 6.45 and the existing chart's  $ARL_1$  is 15.85 (see in table 3).

### C. RSNPDEBLP CONTROL CHART VERSUS RSNPSE CONTROL CHART

This part deals with the lead of the RSNPDEBLP control chart as competed to the RSNPSE control chart which is designed by [22]. In Table 3, the determined ARLs for new control chart shows the fast decreasing trend in contrast to Reference [22] control chart at different values of  $\lambda$ , n, and shift. For example, when  $\lambda = 0.05$ ,  $p_1 = 0.65$  and n = 10, the  $ARL_1 = 4.77$  for proposed control chart and  $ARL_1 = 0.75$  for the existing control chart. Also, the efficiency of the proposed control chart increases for large shift values for example when  $\lambda = 0.25$  and n = 20, the  $ARL_1 = 2.04$  and existing chart's  $ARL_1 = 3.13$ .

### D. RSNPDEBLP CONTROL CHART VERSUS NPASME CONTROL CHART

A review of newly designed control chart with a nonparametric Modified EWMA sign control chart designed by [33] are described in this section. The comparison has shown that, the proposed control chart gives smaller value of OOC  $ARL_1$ and existing control chart gives a larger value of OOC  $ARL_1$ . For example, when  $\lambda = 0.05$ ,  $p_1 = 0.6$  and n = 10, the new control chart  $ARL_1$  value is 8.62, while  $ARL_1 = 19.22$  for the existing control chart. Furthermore, when sample size is increasing from 10 to 20 with same  $\lambda$  value but the ARL<sub>1</sub> decreasing at every values of  $p_1$ , given in Table 3. Alongside this, in Table 3, when  $\lambda$  and n are increasing at that time the decreasing trend is also justified in the values of all control charts ARL1. However, the ARL1 values of the newly designed control chart decrease rapidly as competed to usual control charts. The detailed comparison of proposed control chart with different existing control charts have been revealed that the proposed control chart shows the greater efficiency to detect a smaller shift in the process. For large values of  $\lambda$ , n and shift the RSNPSE control chart perform efficiently as compared to proposed chart but for small shift and large values of other parameters proposed chart perform efficiently.

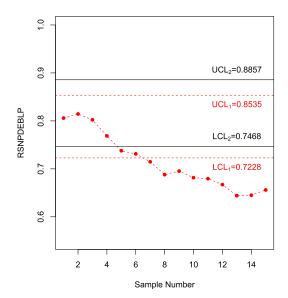
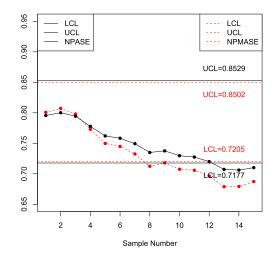


FIGURE 3. Proposed Control chart with n = 10,  $\lambda = 0.05$ ,  $k_1 = 2.21$ ,  $k_2 = 0.84$ .



**FIGURE 4.** NPMASE [33] and NPASE [32] Control chart with n = 10,  $\lambda = 0.05$ , k = 2.595, k = 2.67.

It means that a new control chart presented best as competed to different already planned control charts.

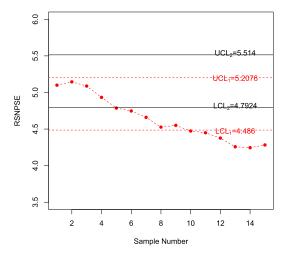
### **V. REAL LIFE IMPLEMENTATION OF PROPOSED CHART**

This section describes the proposed control chart application in everyday life. The data set has been adopted from the [1] "fill volume of soft drink beverage bottles. The volume measure by placing a gauge over the crown and comparing the height of the liquid in the neck of the bottle against a coded scale." The data is defined in Table 4. In this data set, 15 sample size are collected and each sample size has 10 observations. The focus value is supposed to be zero. The  $\lambda = 0.05$  is used for calculating the proposed and existing EWMA, DEWMA sign statistics. The values of control limits coefficients k,  $k_1$  and  $k_2$  are taken from the Table 3. The control chart is developed for the new scheme and existing schemes (NPASE [32], NPASME [33], and RSNPASE [22]).



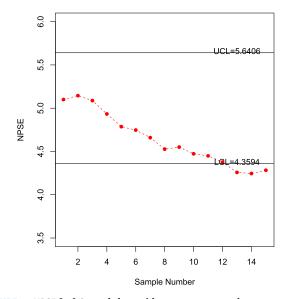
TABLE 4.	The proposed RSNPDEBLE	control chart and existing cor	itrol chart for the data set from the [1].	

Sample	$M_i$	$Y_i$	NPASE	NPASDE	$a_i$	$b_i$	$F_t$	NPASME	NPSE
1	7	0.9911	0.7956	0.7859	0.8054	0.0005	0.8059	0.8008	5.1000
2	6	0.8860	0.8002	0.7866	0.8137	0.0007	0.8144	0.8072	5.1450
3	4	0.6847	0.7944	0.7870	0.8012	0.0004	0.8022	0.7980	5.0877
4	2	0.4636	0.7778	0.7865	0.7692	-0.0004	0.7687	0.7729	4.9333
5	2	0.4636	0.7621	0.7853	0.7390	-0.0012	0.7377	0.7497	4.7866
6	4	0.6847	0.7583	0.7839	0.7326	-0.0013	0.7312	0.7448	4.7473
7	3	0.5796	0.7494	0.7822	0.7164	-0.0017	0.7147	0.7325	4.6599
8	2	0.4636	0.7350	0.7799	0.6902	-0.0023	0.6879	0.7123	4.5269
9	5	0.7853	0.7376	0.7777	0.6974	-0.0021	0.6953	0.7178	4.5506
10	3	0.5796	0.7297	0.7753	0.6840	-0.0024	0.6816	0.7074	4.4731
11	4	0.6847	0.7274	0.7729	0.6819	-0.0023	0.6795	0.7057	4.4494
12	3	0.5796	0.7200	0.7703	0.6697	-0.0026	0.6671	0.6962	4.3769
13	2	0.4636	0.7072	0.7671	0.6473	-0.0031	0.6441	0.6788	4.2581
14	4	0.6847	0.7061	0.7641	0.6481	-0.0030	0.6450	0.6792	4.2452
15	5	0.7853	0.7100	0.7614	0.6587	-0.0027	0.6560	0.6872	4.2829



**FIGURE 5.** RSNPSE [22] Control chart with  $n = 10, \lambda = 0.05, k_1 = 2.84, k_2 = 0.56.$ 

Moreover, the control limits of the new control chart are estimated as  $LCL_1 = 0.7228$ ,  $LCL_2 = 0.7486$ ,  $UCL_1 = 0.9083$ and  $UCL_2 = 0.8321$ . The RSNPDEWBLP is plotted against their calculated control limits in Figure 3. Beside that the new designed control chart trigger the OOC value in sample 6. The NPASE [32] and NPASME [33] control chart is plotted in figure 4 that showed the OOC signal NPASE in sample 12 and NPASME in sample 8. From Figure 3 and 4, it is observed the RSNPDEBLP control chart triggers the OOC signal 6 time earlier as compared to existing control chart NPASE [32] control chart. However, in Figure 4 the existing control chart NPASME [33] detects the OOC signal 4 times efficiently as compared to NPASE [22] control chart in Figure 4. But new control chart detecting the OOC value 3 times earlier as compared to existing control chart NPASME [33] shown in Figure 4. A repetitive sampling scheme control chart is plotted in Figure 5, that proposed by [22]. This control chart showed the OOC signal in sample 9, while it also less efficient as compared to NPASME [33] and proposed control chart too. Therefore, from Figures 3-6, it can be seen that the proposed RSNPDEBLP control chart performs best than the three existing control charts in accommodating the quick indication of



**FIGURE 6.** NPSE [32] Control chart with n = 10,  $\lambda = 0.05$ , k = 2.67.

a shift in the process. Thus the appropriate explanation of the new control chart will lead to a fall in the frequency of defective goods. It has been noted that the control chart NPASME proposed by [33] is detecting the OOC signal more efficiently than the proposed charts in [22] and [32]. As like this RSNPSE control chart [22] detects OOC signal faster as compared to the NPASE control chart offered [32]. After this explanation, we can say that the proposed control chart perform more efficiently as compared to all existing control charts.

### VI. CONCLUSION

The OOC average run length  $ARL_1$  values under linear drift for different  $p_1$  values were used for checking the efficiency of the proposed control chart with some existing control charts. The RSNPDEBLP control chart has smallest OOC ARL value which is considered as the best control chart. The major purpose of the control chart was to identify an OOC value as rapidly as achievable for getting the non-defective pieces in the production process or avoid the non-defective



items' production during the manufacturing process. So, the control chart having lower values of the OOC ARL is observed as the efficient control chart for checking the procedure. Table 3 perform the assessment of existing control charts (NPSE, NPASE [32], NPASDE, NPASME [33], RSNPSE [22], and new RSNPDEBLP) control chart for several values of n and  $\lambda$ . The proposed control chart is best for detecting the OOC signals in the process for small to moderate linear trend as competed to the existing EWMA and DEWMA control charts (see table 3). This procedure was repeated several times using the different values of n, and  $\lambda$ for the slop  $p_1$ . For example, when  $\lambda = 0.05$  and n = 10, 20, it can be observed in Table 3 the OOC ARL<sub>1</sub> values of the RSNPDEBLP control chart are smaller than the  $ARL_1$  of the other control charts only when magnitude shift ( $\delta = |p_0 - p_1|$ ) has large deviations in the process proportion. Moreover, ARL<sub>1</sub> value of RSNPDEBLP control chart is smaller than the  $ARL_1$  values of the existing control charts while  $p_1 < 0.40$ or magnitude shift  $\delta > 0.10$ . Conclusively, it is noted that for different values of  $\lambda$ , n in Table 1 to 4, the OOC ARL values of RSNPDEBLP control chart are less than the  $ARL_1$  values of other control chart for slope values. Hence, the proposed control chart is more efficient than the existing control charts in identifying the process shift.

## APPENDIXES APPENDIX A

A. The variance of DEWMA statistics Control is:

$$Var(Z_i) = \frac{\lambda^4}{4n((1-(1-\lambda)^2)^3)} (1+(1-\lambda)^2-(1-\lambda)^{2i})$$

$$((i+1)^2-(2i^2+2i-1)(1-\lambda)^2+i^2(1-\lambda^4))) \qquad (23)$$

A.1. Mean  $a_i$  can be verified by using equations (3) and (7).

$$E(a_i) = E(2Z_i - Z_i')$$

$$= 2E(Z_i) - E(Z_i')$$

$$= 2\sin^{-1}\sqrt{p_0} - \sin^{-1}\sqrt{p_0}$$

$$= \sin^{-1}\sqrt{p_0}$$

A.2. The asymptotic variance of  $a_i$  can be derived by using the (5) and (9).

$$Var_{asym}(a_i) = V(2Z_i - Z_i')$$

$$= 4V(Z_i) - V(Z_i') + 4 Cov(Z_i, Z_i')$$

$$= 4V(Z_i) - V(Z_i') + 4(0)$$

$$= 4(\frac{\lambda}{(2-\lambda)4n}) - (\frac{\lambda(2-2\lambda+\lambda^2}{(2-\lambda)^3} \frac{1}{4n})$$

$$= \frac{4}{4n}(\frac{\lambda}{(2-\lambda)}) - (\frac{\lambda(2-2\lambda+\lambda^2}{(2-\lambda)^3} \frac{1}{4n})$$

$$= \frac{\lambda(1+4(1-\lambda)+5(1-\lambda)^2)}{(1+(1-\lambda))^2(4n)}$$

A.3.

$$E(b_i) = E(\frac{\lambda}{1 - \lambda} Z_i - Z_i'))$$

$$= \frac{\lambda}{1 - \lambda} (EZ_i) - E(Z_i'))$$

$$= \frac{\lambda}{1 - \lambda} (\sin^{-1} \sqrt{p_0} - (\sin^{-1} \sqrt{p_0}))$$

$$= 0$$

A.4. The variance of slop  $b_i$  is defined as:

$$Var(b_i) = Var(\frac{\lambda}{1-\lambda}(Z_i - Z_i'))$$

$$= (\frac{\lambda}{1-\lambda})^2 Var(Z_i - Z_i')$$

$$= (\frac{\lambda}{1-\lambda})^2 (\frac{\lambda}{(2-\lambda)4n} - \frac{\lambda(2-2\lambda+\lambda^2)}{(2-\lambda)^3} \frac{1}{4n})$$

$$= \frac{2\lambda^3}{(1+(1-\lambda))^3(4n)}$$

#### **APPENDIX B**

B.1. The expected value of linear prediction  $f_t$  can be calculated by using the A1. and A.3.

$$E(F_{i+t}) = E(a_i + b_i t)$$

$$= E(a_i) + tE(b_i)$$

$$= \sin^{-1} \sqrt{p_0} + 0$$

$$= \sin^{-1} \sqrt{p_0}$$

B.2. The Variance of  $F_t$  is

$$Var(F_{i+t}) = Var(a_i + b_i t)$$
  
=  $Var(a_i) + Var(b_i t) + 2 Cov(a_i, b_i t)$ 

The covariance process in the above equation was investigate by using the simulation to verify the possible relationship between  $a_i$  and  $b_i$ . Simulation for the covariance relationship between the  $a_i$  and  $b_i$  were performed for different values of  $\lambda$  which is a smooth parameter in this process. The  $Cov(a_i, b_i)$  simulated values very close to zero and it can be supped negligible. Moreover, the asymptotic  $Cov(a_i, b_i)$  for t = 1 introduced by [27] and it can be written as:

$$Cov(a_i, b_i) = \frac{\lambda^2 (1 + 3(1 - \lambda))}{(1 + (1 - \lambda))^3 (4n)}$$

By using the Appendix A.2 and A.4 in above equation and calculate the asymptotic variance of the linear trend production  $F_t$  as below:

$$\begin{aligned} Var_{asym}(F_t) &= A.2 + A.4 + Cov(a_i, b_i t) \\ &= \frac{\lambda(1 + 4(1 - \lambda) + 5(1 - \lambda)^2)}{(1 + (1 - \lambda))^2(4n)} \\ &+ \frac{2\lambda^3}{(1 + (1 - \lambda))^3(4n)} + \frac{\lambda^2(1 + 3(1 - \lambda))}{(1 + (1 - \lambda))^3(4n)} \\ &= \frac{1}{4n} (\frac{\lambda(1 + 4(1 - \lambda) + 5(1 - \lambda)^2)}{(1 + (1 - \lambda))^2} \\ &+ \frac{2\lambda^3}{(1 + (1 - \lambda))^3} + \frac{\lambda^2(1 + 3(1 - \lambda))}{(1 + (1 - \lambda))^3}) \end{aligned}$$



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#### REFERENCES

- D. C. Montgomery, Introduction to Statistical Quality Control, 6th ed. New York, NY, USA: Wiley, 2009. [Online]. Available: https://www.academia.edu
- [2] W. A. Shewhart, Economic Control of Quality of Manufactured Product. London, U.K.: Macmillan, 1931. [Online]. Available: https://www. gipe.ac.in
- [3] S. W. Roberts, "Control chart tests based on geometric moving averages," *Technometrics*, vol. 1, no. 3, pp. 239–250, Aug. 1959.
- [4] E. S. Page, "Continuous inspection schemes," Biometrika, vol. 41, nos. 1–2, pp. 100–115, Jun. 1954.
- [5] W. H. Woodall, "The use of control charts in health-care and public-health surveillance," J. Qual. Technol., vol. 38, no. 2, pp. 89–104, Apr. 2006.
- [6] P. Masson, "Quality control techniques for routine analysis with liquid chromatography in laboratories," *J. Chromatography A*, vol. 1158, nos. 1–2, pp. 168–173, Jul. 2007.
- [7] S. A. Abbasi, "On the performance of EWMA chart in the presence of twocomponent measurement error," *Qual. Eng.*, vol. 22, no. 3, pp. 199–213, Jun. 2010.
- [8] S.-L. Hwang, J.-T. Lin, G.-F. Liang, Y.-J. Yau, T.-C. Yenn, and C.-C. Hsu, "Application control chart concepts of designing a pre-alarm system in the nuclear power plant control room," *Nucl. Eng. Des.*, vol. 238, no. 12, pp. 3522–3527, Dec. 2008.
- [9] Z. Wang and R. Liang, R. "Discuss on applying SPC to quality management in University education," in *Proc. 9th Int. Conf. Young Comput. Scientists (ICYCS)*, Nov. 2008, pp. 2372–2375. [Online]. Available: https://ieeexplore.ieee.org
- [10] S. E. Shamma and A. K. Shamma, "Development and evaluation of control charts using double exponentially weighted moving averages," *Int. J. Qual. Rel. Manage.*, vol. 9, no. 6, pp. 18–25, Jun. 1992.
- [11] L. Zhang and G. Chen, "An extended EWMA mean chart," *Qual. Technol. Quant. Manage.*, vol. 2, no. 1, pp. 39–52, Jan. 2005.
- [12] M. B. C. Khoo, S. Y. Teh, and Z. Wu, "Monitoring process mean and variability with one double EWMA chart," *Commun. Statist.-Theory Methods*, vol. 39, no. 20, pp. 3678–3694, Oct. 2010.
- [13] S. S. Alkahtani, "Robustness of DEWMA versus EWMA control charts to non-normal processes," *J. Mod. Appl. Stat. Methods*, vol. 12, no. 1, pp. 148–163, 2013.
- [14] L. Zhang, K. Govindaraju, C. D. Lai, and M. S. Bebbington, "Poisson DEWMA control chart," *Commun. Statist.-Simul. Comput.*, vol. 32, no. 4, pp. 1265–1283, Jan. 2003.
- [15] M. A. Mahmoud and W. H. Woodall, "An evaluation of the double exponentially weighted moving average control chart," *Commun. Statist.-Simul. Comput.*, vol. 39, no. 5, pp. 933–949, Apr. 2010.
- [16] S. Alkahtani and J. Schaffer, "A double multivariate exponentially weighted moving average (dMEWMA) control chart for a process location monitoring," *Commun. Statist.-Simul. Comput.*, vol. 41, no. 2, pp. 238–252, Feb. 2012.
- [17] S. Knoth, "More on control charting under drift," in Frontiers in Statistical Quality Control 10. Heidelberg, Germany: Physica, 2012, pp. 53–67.
- [18] M. S. Saccucci, R. W. Amin, and J. M. Lucas, "Exponentially weighted moving average control schemes with variable sampling intervals," *Commun. Statist.-Simul. Comput.*, vol. 21, no. 3, pp. 627–657, Jan. 1992.
- [19] R. Croasdale, "Control charts for a double-sampling scheme based on average production run lengths," *Int. J. Prod. Res.*, vol. 12, no. 5, pp. 585–592, Jan. 1974.
- [20] R. E. Sherman, "Design and evaluation of a repetitive group sampling plan," *Technometrics*, vol. 7, no. 1, pp. 11–21, Feb. 1965.
- [21] S. Balamurali and C.-H. Jun, "Repetitive group sampling procedure for variables inspection," *J. Appl. Statist.*, vol. 33, no. 3, pp. 327–338, Apr. 2006.
- [22] M. Aslam, M. Azam, and C.-H. Jun, "A new exponentially weighted moving average sign chart using repetitive sampling," *J. Process Control*, vol. 24, no. 7, pp. 1149–1153, Jul. 2014.

- [23] L. Ahmad, M. Aslam, and C.-H. Jun, "Designing of X-bar control charts based on process capability index using repetitive sampling," *Trans. Inst. Meas. Control*, vol. 36, no. 3, pp. 367–374, May 2014.
- [24] M. Aslam, N. Khan, M. Azam, and C.-H. Jun, "Designing of a new monitoring T-chart using repetitive sampling," *Inf. Sci.*, vol. 269, pp. 210–216, Jun. 2014.
- [25] M. Azam, M. Aslam, and C.-H. Jun, "Designing of a hybrid exponentially weighted moving average control chart using repetitive sampling," *Int.* J. Adv. Manuf. Technol., vol. 77, nos. 9–12, pp. 1927–1933, Apr. 2015.
- [26] M. Aslam, N. Khan, and C.-H. Jun, "A new S<sup>2</sup> control chart using repetitive sampling," J. Appl. Statist., vol. 42, no. 11, pp. 2485–2496, Nov. 2015.
- [27] R.G. Brown, Smoothing, Forecasting and Prediction of Discrete Time Series. North Chelmsford, MA, USA: Courier Corporation, 2004. [Online]. Available: https://books.google.com
- [28] J. E. Hanke, A. G. Reitsch, and D. W. Wichern, Business Forecasting. Upper Saddle River, NJ, USA: Prentice-Hall, Jan. 2001. [Online]. Availabe: https://academia.edu
- [29] R. P. Abreu and J. R. Schaffer, "A double EWMA control chart for the individuals based on a linear prediction," J. Mod. Appl. Stat. Methods, vol. 16, no. 2, pp. 443–457, 2017.
- [30] R. G. Brown and R. F. Meyer, "The fundamental theorem of exponential smoothing," *Oper. Res.*, vol. 9, no. 5, pp. 673–685, Oct. 1961.
- [31] M. Riaza and S. A. Abbasib, "Nonparametric double EWMA control chart for process monitoring," *Revista Colombiana de Estadística*, vol. 39, no. 2, pp. 167–184, 2016.
- [32] S. Yang, J. Lin, and S. W. Cheng, "A new nonparametric EWMA sign control chart," Expert Syst. Appl, vol. 38, no. 5, pp. 6239–6243, May 2011.
- [33] M. Aslam, M. Ali Raza, M. Azam, L. Ahmad, and C.-H. Jun, "Design of a sign chart using a new EWMA statistic," *Commun. Statist.-Theory Methods*, vol. 49, no. 6, pp. 1299–1310, Mar. 2020.
- [34] D. C. Montgomery, Introduction to Statistical Quality Control. Hoboken, NJ, USA: Wiley, 2007.
- [35] F. Mosteller and C. Youtz, "Tables of the Freeman-Tukey transformations for the binomial and Poisson distributions," in *Selected Papers of Frederick Mosteller*, D. C. Hoaglin, Ed. New York, NY, USA: Springer, 2006, pp. 47–337. [Online]: Available: https://link.springer.com
- [36] M. Aslam, "Control chart for variance using repetitive sampling under neutrosophic statistical interval system," *IEEE Access*, vol. 7, pp. 25253–25262, Feb. 2019.
- [37] N. MS, M. Azam, and M. Aslam, "EWMA and DEWMA repetitive control charts under non-normal processes," *J. Appl. Statist.*, vol. 47, pp. 1–37, Jan. 2020. [Online]: Available: https://www.tandfonline.com/doi/full/10.1080/02664763.2019.1709809
- [38] R. G. Brown, Smoothing, Forecasting and Prediction of Discrete Time Series. New York, NY, USA: Prentice-Hall, 2004.



**AMBREEN SHAFQAT** is currently pursuing the Ph.D. degree in statistics form the Nanjing University of Science and Technology, Nanjing, China, with Nanjing Government Scholarship. Her current research interests include statistical process control, reliability, nonparametric, industrial statistics, and acceptance sampling.



**ZHENSHENG HUANG** received the M.Sc. degree in statistics from Anhui Normal University, in 2005, and the Ph.D. degree in statistics from East China Normal, in 2010. He was a Researcher with the Department of Mathematics, Nanyang Technological University, Singapore, from 2011 to 2012. He has been a Full Professor with the Department of Statistics and Financial Mathematics, Nanjing University of Science and Technology, since 2012. He is a member of the Academic

Committee, Nanjing University of Science and Technology and Communications, and a Reviewer of the National Natural Science Foundation of China. He received the Endeavor Award from the Australian Federal Government, in 2011. He received the Outstanding Ph.D. Thesis Award from Shanghai, in 2012. He also received the Blue Project of young academic leaders in Jiangsu, in 2016.





MUHAMMAD ASLAM received the M.Sc. degree in statistics from GC University Lahore, in 2004, with the Chief Minister of the Punjab Merit Scholarship, the M.Phil. degree in statistics from GC University Lahore, in 2006, with the Governor of the Punjab Merit Scholarship, and the Ph.D. degree in statistics from the National College of Business Administration and Economics Lahore, in 2010, under the supervision of Dr. M. Ahmad. He was a Lecturer of statistics with the

Edge College System International, from 2003 to 2006. He was a Research Assistant with the Department of Statistics, GC University Lahore, from 2006 to 2008. He joined the Forman Christian College University, as a Lecturer, in 2009, where he was an Assistant Professor, from 2010 to 2012, and then as an Associate Professor, from 2012 to 2014. He was an Associate Professor of statistics with the Department of Statistics, Faculty of Science, King Abdulaziz University, Jeddah, Saudi Arabia, from 2014 to 2017, where he is currently a Full Professor of statistics with the Department of Statistics. He taught summer course as a Visiting Faculty of statistics with Beijing Jiaotong University, China, in 2016. He has published more than 390 research articles in national and international well-reputed journals, including for example, IEEE Access, the Journal of Applied Statistics, the European Journal of Operational Research, Information Sciences, the Journal of Process Control, the Journal of the Operational Research Society, Applied Mathematical Modeling, The International Journal of Advanced Manufacturing Technology, Communications in Statistics, the Journal of Testing and Evaluation, and the Pakistan Journal of Statistics. His articles have been cited more than 2400 times with H-index 25 and i-10 index 68 (Google Coalitions). His articles have also been cited more than 1200 times with H-index 20 (Web of Science Coalitions). He has authored one book published in Germany. His research interests include reliability, decision trees, industrial statistics, acceptance sampling, rank set sampling, neutrosophic statistics, and applied statistics. He is a member of the Islamic Countries Society of Statistical Sciences. He received Meritorious Services Award in Research from the National College of Business Administration and Economics, Lahore, in 2011, and the Research Productivity Award for the year 2012 by the Pakistan Council for Science and Technology. He is selected for the Innovative Academic Research and Dedicated Faculty Award 2017 by SPE, Malaysia. He received the King Abdulaziz University Excellence awards in Scientific Research for the article Aslam, M., Azam, M., Khan, N., and Jun, C.-H., in 2015. A New Mixed Control Chart to Monitor the Process, International Journal of Production Research, 53 (15), 4684-4693. He received the King Abdulaziz University Citation Award for the article Azam, M., Aslam, M., and Jun, C.-H., in 2015. Designing of a hybrid exponentially weighted moving average control chart using repetitive sampling, International Journal of Advanced Manufacturing Technology, 77:1927-1933, in 2018. He is a member of the Editorial Board of the Electronic Journal of Applied Statistical Analysis, the Asian Journal of Applied Science and Technology, and the Pakistan Journal of Commerce and Social Sciences. He has also been HEC approved Ph.D. Supervisor, since 2011. He has supervised five Ph.D. theses, more than 25 M.Phil. theses, and three M.Sc. theses. He is also supervising one Ph.D. thesis and more than five M.Phil. theses in statistics. He is a Reviewer of more than 50 well-reputed international journals. He has reviewed more than 140 research articles for various well-reputed international journals. His name listed at second position among Statistician in the Directory of Productivity Scientists of Pakistan, in 2013, and also listed at first position, in 2014. He got 371 positions in the list of top 2210 profiles of Scientist of Saudi Institutions, in 2016. He was appointed as an External Examiner for 2016/2017–2018/2019 triennium with The University of Dodoma, Tanzania.



MUHAMMAD SHUJAAT NAWAZ received the M.Sc. degree in statistics from the University of the Punjab, Lahore, Pakistan, and the M.Phil. degree in statistics from the National College of Business Administration and Economics, Lahore, Pakistan. He had worked as the Assistant Director of statistics with the State Bank of Pakistan, Karachi, Pakistan. He taught several graduate level courses of statistics in different universities from time to time. He is currently working as a Lecturer

with Higher Education Department. He is also completing a research as compulsory requirement. His research interests include acceptance sampling, control charts, probability, and time series. He received the Silver Medal for his M.Sc. degree.

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